

20V P-CHANNEL ENHANCEMENT MODE MOSFET

Summary

V _{DSS}	R _{DS(ON)} max	I _D max T _A = +25°C
-20V	$24m\Omega @V_{GS} = -4.5V$	-6.6 A
200	$31m\Omega @V_{GS} = -2.5V$	-5.8 A

Features and Benefits

- Typical Off Board Profile of 0.575mm Ideally Suited for Thin Applications
- Low R_{DS(ON)} Minimizes Conduction Losses
- PCB Footprint of 2.56mm²
- ESD Protected Gate 2kV
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 standards for High Reliability

Applications

This new generation MOSFET is designed to minimize the on-state resistance ($R_{DS(ON)}$) and yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

- Power Management Functions
- Analog Switches

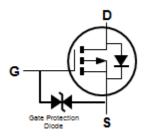
Mechanical Data

- Case: U-DFN1616-6
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Lead Free Plating (NiPdAu Finish over Copper Leadframe).
- Terminals: Solderable per MIL-STD-202, Method 208 @4
- Weight: 0.04 grams (Approximate)

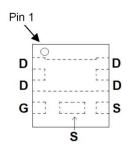


Top View

Bottom View



Device Symbol



Top View Pin-Out

Ordering Information (Note 4)

Product	Case	Packaging
DMP2035UFCL-7	U-DFN1616-6	3,000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com.

Marking Information



25P = Product Type Marking Code YM = Date Code Marking Y = Year (ex: C = 2015) M = Month (ex: 9 = September)

Date Code Key

Year	201	5	2016		2017	20	18	2019		2020	2	2021
Code	С		D		Е	l l	=	G		Н		
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings (@ $T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic		Symbol	Value	Units	
Drain-Source Voltage	V_{DSS}	-20	V		
Gate-Source Voltage	V_{GSS}	±8	V		
Continuous Drain Current (Note 6)	Steady State	$T_A = +25$ °C $T_A = +70$ °C	In.	-6.6 -5.3	Α
Pulsed Drain Current (380µs Pulse, 1% Duty Cyc	ele)(Note 7)	I _{DM}	-40	Α	
Maximum Continuous Body Diode Forward Curre	ent (Note 6)	Is	-1.7	Α	

Thermal Characteristics (@ $T_A = +25$ °C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 5)	P_{D}	0.74	W
Thermal Resistance, Junction to Ambient @T _A = +25°C (Note 5)	$R_{\theta JA}$	169	°C/W
Power Dissipation (Note 6)	P_{D}	1.6	W
Thermal Resistance, Junction to Ambient @T _A = +25°C (Note 6)	$R_{\theta JA}$	79	°C/W
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

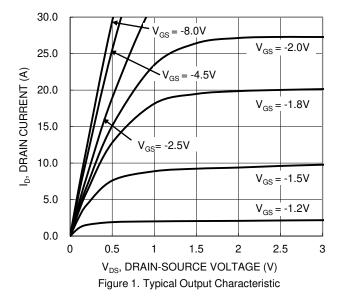
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
DFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BV _{DSS}	-20	-	-	V	V _{GS} = 0V, I _D = -250μA	
Zero Gate Voltage Drain Current $T_J = +25$ °C	I _{DSS}	-	-	-1.0	μA	$V_{DS} = -16V, V_{GS} = 0V$	
Zero Gate Voltage Drain Current T _J = +150°C (Note 8)	I _{DSS}	-	-	-100	μΑ	$V_{DS} = -16V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	-	-	±10	μA	$V_{GS} = \pm 8V$, $V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	V _{GS(TH)}	-0.4	-	-1.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
			19	24		$V_{GS} = -4.5V, I_D = -8.0A$	
Static Drain-Source On-Resistance	R _{DS(ON)}	-	24	31	mΩ	$V_{GS} = -2.5V, I_D = -7.0A$	
	, ,		31	45		$V_{GS} = -1.8V, I_{D} = -6.0A$	
Diode Forward Voltage	V_{SD}	-0.5	-0.7	-1.2	V	V _{GS} = 0V, I _S = -1A	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	C _{iss}		1,610	2,200	рF	101/11/01/	
Output Capacitance	Coss	-	157	240	рF	$V_{DS} = -10V, V_{GS} = 0V$ - f = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}	-	145	220	pF	1 = 1.000112	
Gate Resistance	R_g	-	9.45	14.5	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge (V _{GS} = -8V)	Qg	-	29	44	nC		
Total Gate Charge (V _{GS} = -4.5V)	Qg	-	15.4	21	nC	$V_{DS} = -10V$,	
Gate-Source Charge	Q _{qs}	-	2.5	3.8	nC	$I_D = -4A$	
Gate-Drain Charge	Q _{qd}	-	3.3	5	nC		
Turn-On Delay Time	t _{D(ON)}	-	16.8	34	ns		
Turn-On Rise Time	t _R	-	12.4	25	ns	$V_{DS} = -20V, V_{GS} = -10V,$	
Turn-Off Delay Time	t _{D(OFF)}	-	94.1	188	ns	$R_G = 6.0\Omega, I_D = -6A$	
Turn-Off Fall Time	t _F	-	42.4	85	ns		

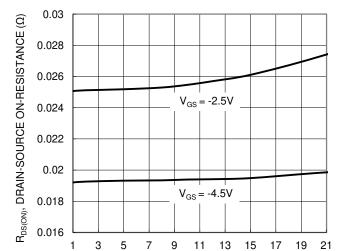
Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
 Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
 Repetitive rating, pulse width limited by junction temperature.

Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to product testing.









I_D, DRAIN-SOURCE CURRENT (A) Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

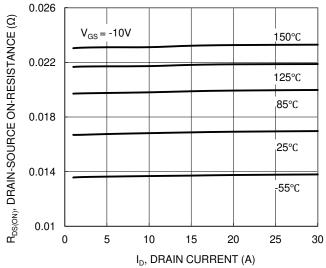


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature

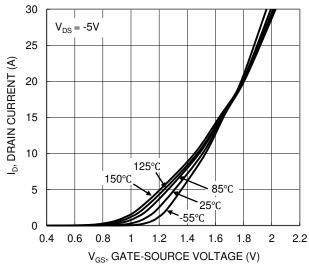


Figure 2. Typical Transfer Characteristic

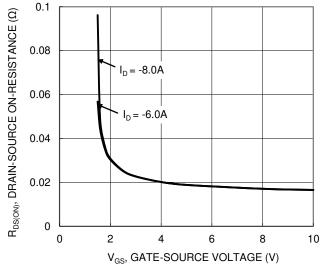


Figure 4. Typical Transfer Characteristic

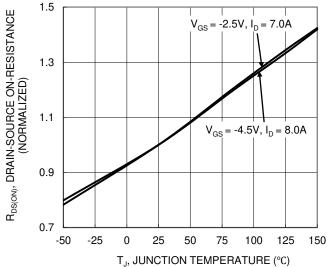
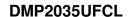


Figure 6. On-Resistance Variation with Junction Temperature





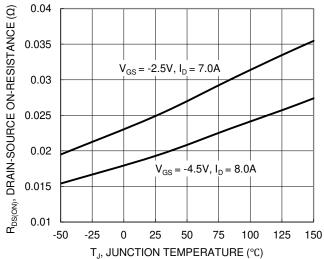


Figure 7. On-Resistance Variation with Junction Temperature

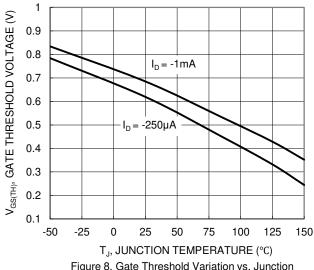


Figure 8. Gate Threshold Variation vs. Junction Temperature

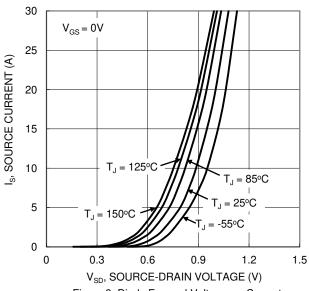


Figure 9. Diode Forward Voltage vs. Current

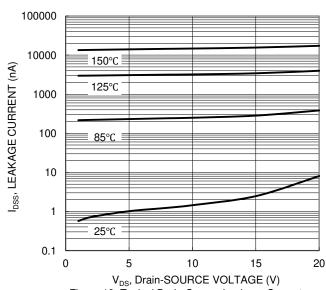
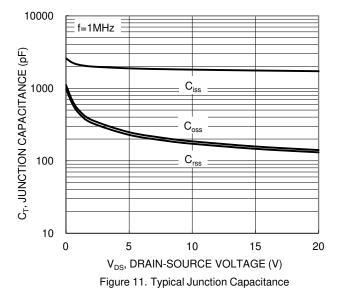


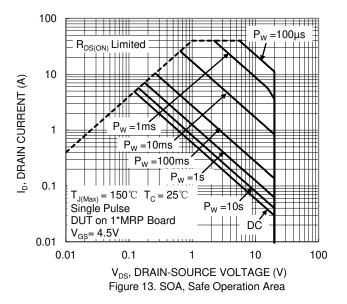
Figure 10. Typical Drain-Source Leakage Current vs.
Voltage



6 V_{DS} = -10V, I_D = -4A V_{DS} = -10V, I_D = -4A Q_q (nC)

8





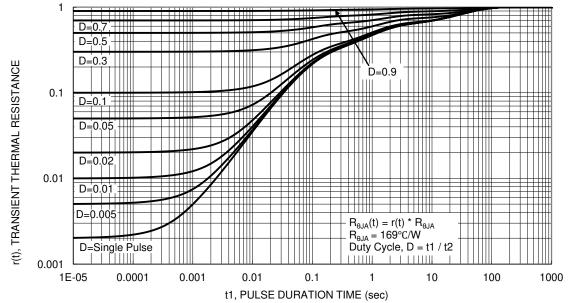
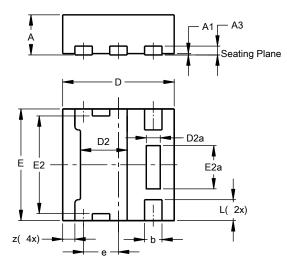


Figure 14. Transient Thermal Resistance



Package Outline Dimensions

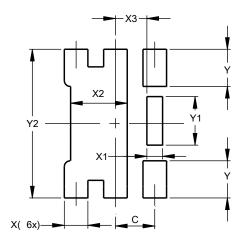
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.



U-DFN1616-6 (Type K)						
Dim	Min	Max	Тур			
Α	0.55	0.60	0.575			
A1	0.00	0.05	0.02			
A 3	-	-	0.13			
b	0.20	0.30	0.25			
D	1.55	1.65	1.60			
D2	0.57	0.77	0.67			
D2a	0.10	0.30	0.20			
е			0.50			
Е	1.55	1.65	1.60			
E2	1.30	1.50	1.40			
E2a	0.52	0.72	0.62			
L	0.25	0.35	0.30			
Z			0.175			
All Dimensions in mm						

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value			
Dilliensions	(in mm)			
С	0.500			
X	0.300			
X1	0.200			
X2	0.720			
Х3	0.400			
Υ	0.475			
Y1	0.620			
Y2	1.900			



IMPORTANT NOTICE

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel. Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

This document is written in English but may be translated into multiple languages for reference. Only the English version of this document is the final and determinative format released by Diodes Incorporated.

LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

- A. Life support devices or systems are devices or systems which:
 - 1. are intended to implant into the body, or
 - 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
- B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

Copyright © 2015, Diodes Incorporated

www.diodes.com